



Atty.
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Client Ref.

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Applicant: TOHGI et al.

Appln. No.: 10/757,120

Filing Date: January 14, 2004

Examiner: Unknown

Group Art Unit: Unknown

Date: February 26, 2004

Page

1

of

1

U.S. PATENT DOCUMENTS

Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
FE	AR	5,854,619	12/29/1998	KATO			6/29/1995
	BR						
	CR						
	DR						
	ER						
	FR						
	GR						
	HR						
	IR						
	JR						

FOREIGN PATENT DOCUMENTS

	Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract	Translation Readily Available
					Enclosed	No
	KR					
	LR					
	MR					
	NR					
	OR					
	PR					
	QR					
	RR					

OTHER (including in this order: Author, Title, Periodical Name, Date, Pertinent Pages, etc.):

	SR					
	TR					
	UR					
	VR					
	WR					

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**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: Tohgi et al.
Appln. No.: 10/757,120
Filing Date: January 14, 2004
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Group Art Unit: 2171

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Page 1 of 1

U.S. PATENT DOCUMENTS

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AR						
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CR						
DR						
ER						

FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclosed	No
FE	FR	10-247091	09/1998	Japan	Sone, Takuro	x			
FE	GR	2002-203117	07/2002	Japan	Tajima, Yoshiyuki	x			
HR									
IR									
JR									

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

KR	Copy of Japan Patent Office Office Action mailed on February 28, 2006, issued in corresponding Japanese application No. 2003-006114							x	
LR									
MR									
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PR									
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